74HC3G14; 74HCT3G14

Triple inverting Schmitt trigger Rev. 4 — 3 October 2013

Product data sheet

1. **General description**

The 74HC3G14; 74HCT3G14 is a triple inverter with Schmitt-trigger inputs. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V_{CC}. Schmitt trigger inputs transform slowly changing input signals into sharply defined jitter-free output signals.

Features and benefits 2.

- Wide supply voltage range from 2.0 V to 6.0 V
- Input levels:
 - ◆ For 74HC3G14: CMOS level
 - ◆ For 74HCT3G14: TTL level
- High noise immunity
- Low power dissipation
- Balanced propagation delays
- Unlimited input rise and fall times
- Multiple package options
- ESD protection:
 - HBM JESD22-A114E exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

3. Applications

- Wave and pulse shaper for highly noisy environments
- Astable multivibrators
- Monostable multivibrators



4. Ordering information

Table 1. Ordering information

Type number	Package						
	Temperature range	Name	Description	Version			
74HC3G14DP	–40 °C to +125 °C	TSSOP8	plastic thin shrink small outline package; 8 leads;	SOT505-2			
74HCT3G14DP		body width 3 mm; lead length 0.5 mm					
74HC3G14DC	–40 °C to +125 °C	VSSOP8	plastic very thin shrink small outline package; 8 leads;	SOT765-1			
74HCT3G14DC			body width 2.3 mm				
74HC3G14GD	–40 °C to +125 °C	places of the places of the control		SOT996-2			
74HCT3G14GD	8 terminals: hody 3 × 2 × 0.5 mm						

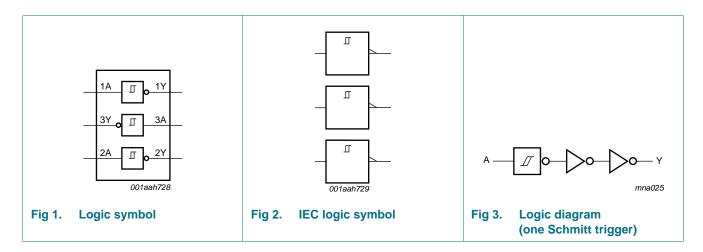
5. Marking

Table 2. Marking

Type number	Marking code ^[1]
74HC3G14DP	H14
74HCT3G14DP	T14
74HC3G14DC	H14
74HCT3G14DC	T14
74HC3G14GD	H14
74HCT3G14GD	T14

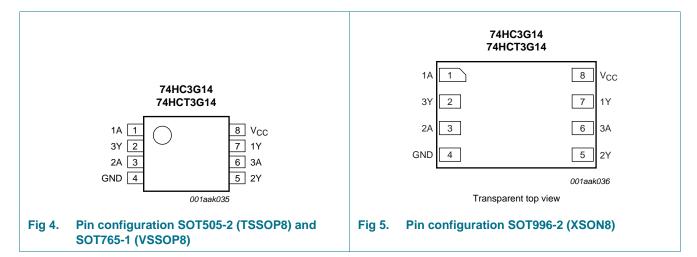
^[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

6. Functional diagram



7. Pinning information

7.1 Pinning



7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1A, 2A, 3A	1, 3, 6	data input
GND	4	ground (0 V)
1Y, 2Y, 3Y	7, 5, 2	data output
V_{CC}	8	supply voltage

8. Functional description

Table 4. Function table[1]

Input	Output
nA	nY
L	Н
Н	L

[1] H = HIGH voltage level; L = LOW voltage level.

9. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7.0	V
I _{IK}	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> -	±20	mA
I _{OK}	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> -	±20	mA
I _O	output current	$V_O = -0.5 \text{ V}$ to $V_{CC} + 0.5 \text{ V}$	<u>[1]</u> -	±25	mA
I _{CC}	supply current		<u>[1]</u> -	+50	mA
I _{GND}	ground current		<u>[1]</u> –50	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation		[2] -	300	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

10. Recommended operating conditions

Table 6. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	7	'4HC3G1	4	7-	Unit		
			Min	Тур	Max	Min	Тур	Max	
V_{CC}	supply voltage	'	2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V_{CC}	0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	0	-	V_{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C

^[2] For TSSOP8 package: above 55 °C the value of P_{tot} derates linearly with 2.5 mW/K. For VSSOP8 package: above 110 °C the value of P_{tot} derates linearly with 8 mW/K. For XSON8 package: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

11. Static characteristics

Table 7. Static characteristics

Voltages are referenced to GND (ground = 0 V). All typical values are measured at T_{amb} = 25 °C.

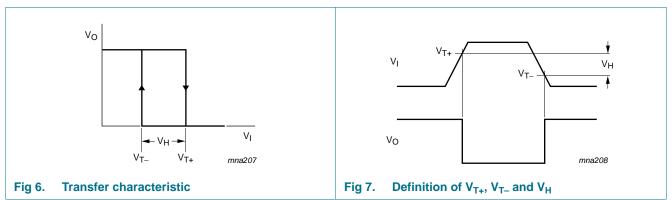
Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C t	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC3G	14					'				
V _{OH}	HIGH-level	$V_I = V_{T+}$ or V_{T-}								
	output voltage	$I_O = -20 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \mu A$; $V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \mu A; V_{CC} = 6.0 V$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	4.18	4.32	-	4.13	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.68	5.81	-	5.63	-	5.2	-	V
V _{OL}	LOW-level	$V_I = V_{T+}$ or V_{T-}								
	output voltage	$I_O = 20 \mu A$; $V_{CC} = 2.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A$; $V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A$; $V_{CC} = 6.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 4.0 \text{ mA}$; $V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
		$I_{O} = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I _{CC}	supply current	per input pin; $V_{CC} = 6.0 \text{ V}$; $V_I = V_{CC}$ or GND; $I_O = 0 \text{ A}$;	-	-	1.0	-	10	-	20	μΑ
Cı	input capacitance		-	2.0	-	-	-	-	-	pF
74HCT3	G14									
V _{OH}	HIGH-level	$V_I = V_{T+}$ or V_{T-}								
	output voltage	$I_O = -20 \mu A$; $V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	4.18	4.32	-	4.13	-	3.7	-	V
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = 20 \mu A$; $V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 4.0 \text{ mA}$; $V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I _{CC}	supply current	per input pin; $V_{CC} = 5.5 \text{ V}$; $V_I = V_{CC}$ or GND; $I_O = 0 \text{ A}$;	-	-	1.0	-	10	-	20	μΑ
Δl _{CC}	additional supply current	per input; $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V};$ $V_{I} = V_{CC} - 2.1 \text{ V}; I_{O} = 0 \text{ A}$	-	-	300	-	375	-	410	μА
Cı	input capacitance		-	2.0	-	-	-	-	-	pF

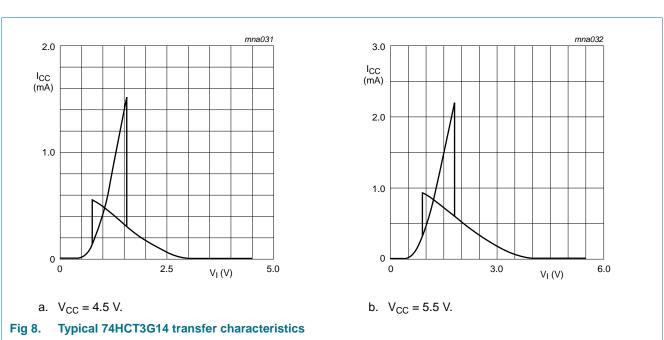
Table 8. Transfer characteristics

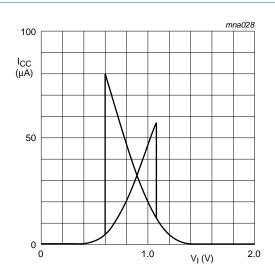
Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 11.

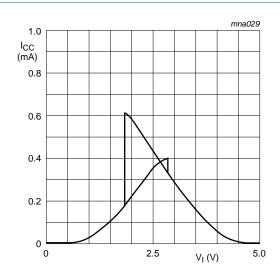
Symbol	Parameter	Conditions		25 °C		-40	0 °C to +1	25 °C	Unit
			Min	Тур	Max	Min	Max (85 °C)	Max (125 °C)	
74HC3G	14		'		'	'			
V_{T+}	positive-going	see Figure 6, Figure 7							
	threshold voltage	$V_{CC} = 2.0 \text{ V}$	1.00	1.18	1.50	1.00	1.50	1.50	V
		$V_{CC} = 4.5 \text{ V}$	2.30	2.60	3.15	2.30	3.15	3.15	V
		$V_{CC} = 6.0 \text{ V}$	3.00	3.46	4.20	3.00	4.20	4.20	V
V_{T-}	negative-going	see Figure 6, Figure 7							
	threshold voltage	$V_{CC} = 2.0 \text{ V}$	0.30	0.60	0.90	0.30	0.90	0.90	V
		V _{CC} = 4.5 V	1.13	1.47	2.00	1.13	2.00	2.00	V
		$V_{CC} = 6.0 \text{ V}$	1.50	2.06	2.60	1.50	2.60	2.60	V
V _H	hysteresis voltage	(V _{T+} − V _{T−}); see <u>Figure 6</u> , <u>Figure 7</u> and <u>Figure 9</u>							
		$V_{CC} = 2.0 \text{ V}$	0.30	0.60	1.00	0.30	1.00	1.00	V
		$V_{CC} = 4.5 \text{ V}$	0.60	1.13	1.40	0.60	1.40	1.40	V
		$V_{CC} = 6.0 \text{ V}$	0.80	1.40	1.70	0.80	1.70	1.70	V
74HCT3	G14								
V_{T+}	positive-going	see Figure 6, Figure 7							
	threshold voltage	$V_{CC} = 4.5 \text{ V}$	1.20	1.58	1.90	1.20	1.90	1.90	V
		$V_{CC} = 5.5 \text{ V}$	1.40	1.78	2.10	1.40	2.10	2.10	V
V_{T-}	negative-going	see Figure 6, Figure 7							
	threshold voltage	$V_{CC} = 4.5 \text{ V}$	0.50	0.87	1.20	0.50	1.20	1.20	V
		$V_{CC} = 5.5 \text{ V}$	0.60	1.11	1.40	0.60	1.40	1.40	V
V _H	hysteresis voltage	$(V_{T+} - V_{T-})$; see <u>Figure 6</u> , <u>Figure 7</u> and <u>Figure 8</u>							
		$V_{CC} = 4.5 \text{ V}$	0.40	0.71	-	0.40	-	-	V
		$V_{CC} = 5.5 \text{ V}$	0.40	0.67	-	0.40	-	-	V

11.1 Waveforms transfer characteristics



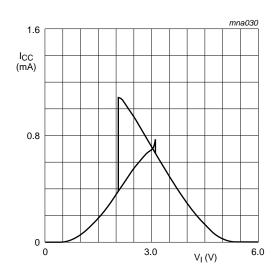






a. $V_{CC} = 2.0 \text{ V}$





c. $V_{CC} = 6.0 \text{ V}$

Fig 9. Typical 74HC3G14 transfer characteristics

12. Dynamic characteristics

Table 9. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 11.

Symbol	Parameter	Conditions			25 °C		-4	0 °C to +1	25 °C	Unit
				Min	Тур	Max	Min	Max (85 °C)	Max (125 °C)	
74HC3G1	4				'	'			'	'
t _{pd}	propagation delay	nA to nY; see Figure 10	<u>[1]</u>							
		V _{CC} = 2.0 V		-	53	125	-	155	190	ns
		V _{CC} = 4.5 V		-	16	25	-	31	38	ns
		V _{CC} = 6.0 V		-	13	21	-	26	32	ns
t _t	transition time	nY; see Figure 10	[2]							
		V _{CC} = 2.0 V		-	20	75	-	95	110	ns
		V _{CC} = 4.5 V		-	7	15	-	19	22	ns
		V _{CC} = 6.0 V		-	5	13	-	16	19	ns
C_{PD}	power dissipation capacitance	$V_I = GND \text{ to } V_{CC}$	[3]	-	10	-	-	-	-	pF
74HCT3G	614									
t _{pd}	propagation delay	nA to nY; see Figure 10	<u>[1]</u>							
		V _{CC} = 4.5 V		-	21	32	-	40	48	ns
t _t	transition time	nY; see Figure 10	[2]							
		V _{CC} = 4.5 V		-	6	15	-	19	22	ns
C_{PD}	power dissipation capacitance	$V_I = GND$ to $V_{CC} - 1.5 V$	[3]	-	10	-	-	-	-	pF

^[1] t_{pd} is the same as t_{PLH} and t_{PHL}

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V;

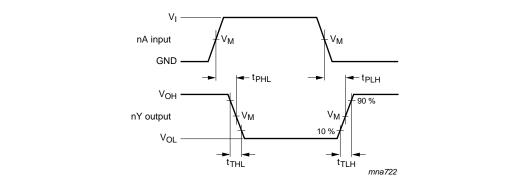
N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.

^[2] t_t is the same as t_{TLH} and t_{THL}

^[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

13. Waveforms



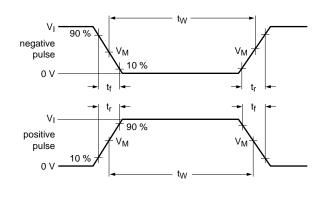
Measurement points are given in Table 10.

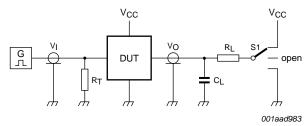
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 10. The data input (nA) to output (nY) propagation delays and output transition times

Table 10. Measurement points

Туре	Input	Output
	V _M	V _M
74HC3G14	0.5V _{CC}	0.5V _{CC}
74HCT3G14	1.3 V	1.3 V





Test data is given in Table 11.

Definitions for test circuit:

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistance.

S1 = Test selection switch.

Fig 11. Test circuit for measuring switching times

Table 11. Test data

Туре	pe Input		Load	S1 position		
	V_{l} t_{r}, t_{f}		C _L	R _L	t _{PHL} , t _{PLH}	
74HC3G14	GND to V_{CC}	≤ 6 ns	50 pF	1 kΩ	open	
74HCT3G14	GND to 3.0 V	≤ 6 ns	50 pF	1 kΩ	open	

14. Application information

The slow input rise and fall times cause additional power dissipation, which can be calculated using the following formula:

 $P_{add} = f_i \times (t_r \times \Delta I_{CC(AV)} + t_f \times \Delta I_{CC(AV)}) \times V_{CC}$ where:

 P_{add} = additional power dissipation (μW);

 $f_i = input frequency (MHz);$

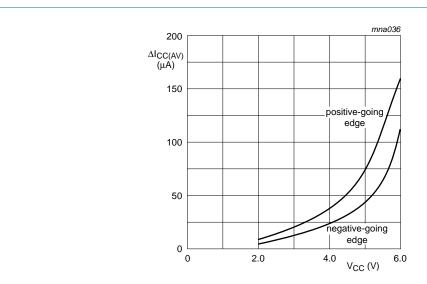
 t_r = input rise time (ns); 10 % to 90 %;

 t_f = input fall time (ns); 90 % to 10 %;

 $\Delta I_{CC(AV)}$ = average additional supply current (μA).

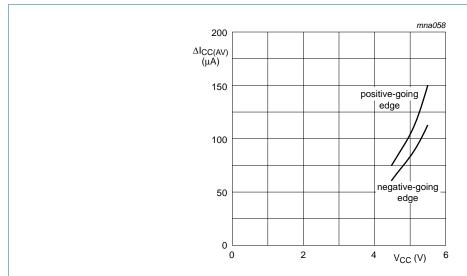
 $\Delta I_{CC(AV)}$ differs with positive or negative input transitions, as shown in <u>Figure 12</u> and <u>Figure 13</u>.

An example of a relaxation circuit using the 74HC3G14/74HCT3G14 is shown in Figure 14.



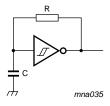
linear change of V_I between 0.1V_{CC} to 0.9V_{CC}.

Fig 12. $\Delta I_{CC(AV)}$ as a function of V_{CC} for 74HC3G14



linear change of V_{I} between $0.1V_{CC}$ to $0.9V_{CC}$.

Fig 13. $\Delta I_{CC(AV)}$ as a function of V_{CC} for 74HCT3G14



For 74HC3G14:
$$f = \frac{1}{T} \approx \frac{1}{0.8 \times RC}$$

For 74HCT3G14:
$$f = \frac{1}{T} \approx \frac{1}{0.67 \times RC}$$

Fig 14. Relaxation oscillator

15. Package outline

TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm SOT505-2

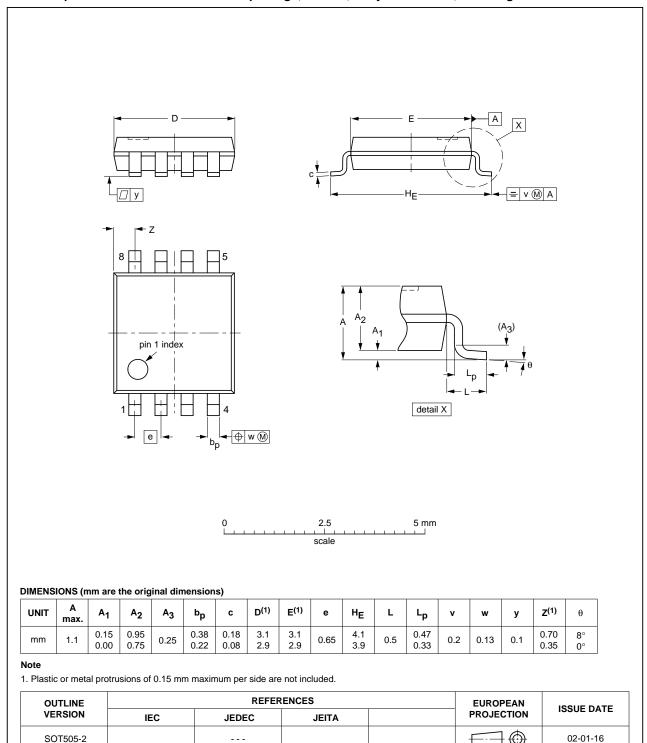
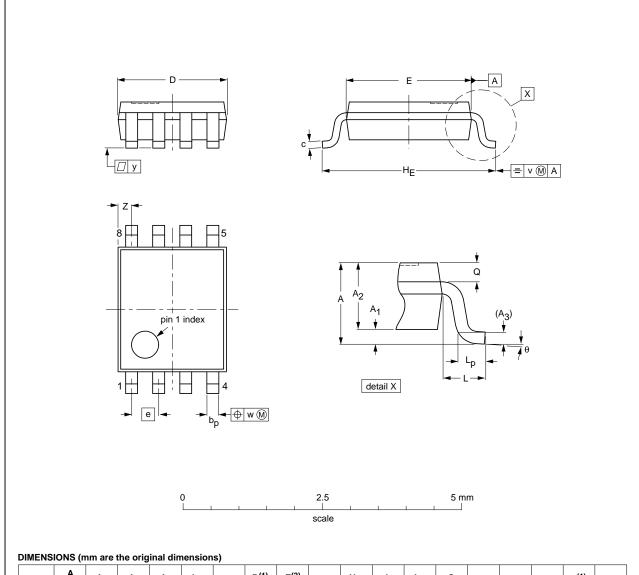


Fig 15. Package outline SOT505-2 (TSSOP8)

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VSSOP8: plastic very thin shrink small outline package; 8 leads; body width 2.3 mm

SOT765-1



UN	IIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
m	m	1	0.15 0.00	0.85 0.60	0.12	0.27 0.17	0.23 0.08	2.1 1.9	2.4 2.2	0.5	3.2 3.0	0.4	0.40 0.15	0.21 0.19	0.2	0.13	0.1	0.4 0.1	8° 0°

Notes

- Plastic or metal protrusions of 0.15 mm maximum per side are not included.
 Plastic or metal protrusions of 0.25 mm maximum per side are not included.

	OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
	SOT765-1		MO-187				02-06-07
		•	•		•		

Fig 16. Package outline SOT765-1 (VSSOP8)

74HC_HCT3G14

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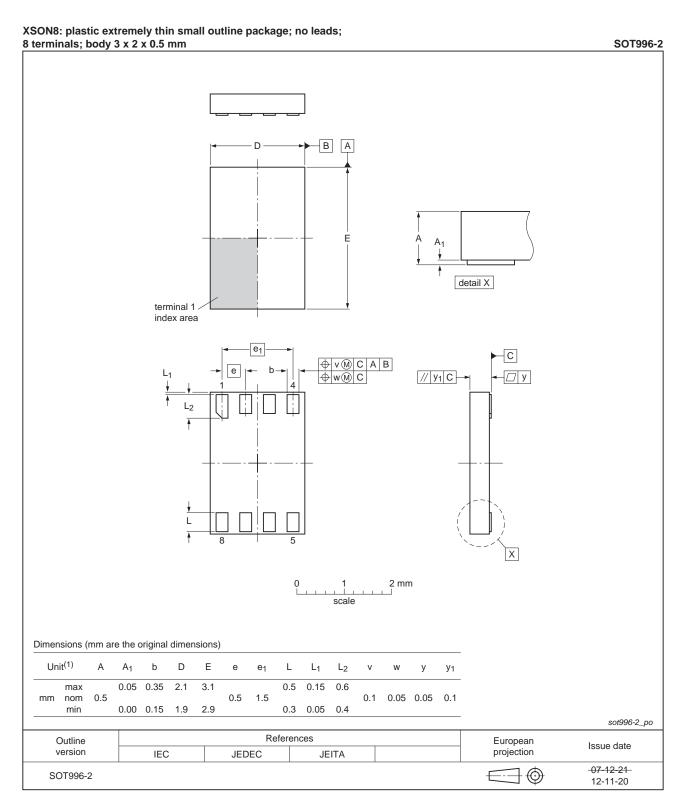


Fig 17. Package outline SOT996-2 (XSON8)

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16. Abbreviations

Table 12. Abbreviations

Acronym	Description	
CMOS	Complementary Metal Oxide Semiconductor	
DUT	Device Under Test	
ESD	ElectroStatic Discharge	
НВМ	Human Body Model	
MM	Machine Model	

17. Revision history

Table 13. Revision history

	-			
Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT3G14 v.4	20131003	Product data sheet	-	74HC_HCT3G14 v.3
Modifications:	 For type null 	mbers 74HC3G14GD and 7	4HCT3G14GD XSON8	U has changed to XSON8.
74HC_HCT3G14 v.3	20090508	Product data sheet	-	74HC_HCT3G14 v.2
74HC_HCT3G14 v.2	20031104	Product specification	-	74HC_HCT3G14 v.1
74HC_HCT3G14 v.1	20020723	Product specification	-	-

18. Legal information

18.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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